



Product Change Notification / ASER-06ZMCM207

Date:

15-Nov-2021

Product Category:

Ethernet Controllers, Ethernet Switches

PCN Type:

Manufacturing Change

Notification Subject:

CCB 4630 Final Notice: Qualification of STA as an additional assembly site for selected LAN9303, LAN9210 and LAN9211 device families available in 56L VQFN (8x8x0.9mm) package.

Affected CPNs:

[ASER-06ZMCM207_Affected_CPN_11152021.pdf](#)

[ASER-06ZMCM207_Affected_CPN_11152021.csv](#)

Notification Text:

PCN Status:Final notification

PCN Type:Manufacturing Change

Microchip Parts Affected:Please open one of the files found in the Affected CPNs section.

NOTE: For your convenience Microchip includes identical files in two formats (.pdf and .xls).

Description of Change:Qualification of STA as an additional assembly site for selected LAN9303, LAN9210 and LAN9211 device families available in 56L VQFN (8x8x0.9mm) package.

Pre and Post Change Summary:

	Pre Change	Post Change	
Assembly Site	ASE Inc. (ASE)	ASE Inc. (ASE)	STATS Chippac Ltd. (STA)

Wire material	PdCu	Au	PdCu	Au	CuPdAu
Die attach material	EN-4900F		EN-4900F		8290
Molding compound material	G631B		G631B		G700E
Lead frame material	C194		C194		C194
Lead frame lead-lock	No		No		No
	See Pre and Post Change Summary for comparison.				
Lead frame paddle size	240x240 mils		240x240 mils		236x236 mils

Impacts to Data Sheet:

None

Change Impact:

None

Reason for Change:

To improve manufacturability by qualifying STA as an additional assembly site

Change Implementation Status:In Progress

Estimated First Ship Date:October 31, 2021 (date code: 2145)

NOTE: Please be advised that after the estimated first ship date customers may receive pre and post change parts.

Time Table Summary:

Workweek	April 2021					->	October 2021				
	14	15	16	17	18		41	42	43	44	45
Initial PCN			X								
Qual Report Availability											
Final PCN Issue Date							X				
Estimated Implementation Date											X

Method to Identify Change:Traceability code

Qualification Report:

Please open the attachments included with this PCN labeled as PCN_#_Qual_Report.

Revision History:

April 14, 2021: Issued initial notification.

October 11, 2021: Issued final notification. Updated the Pre Change field for wire material to include Au (gold) and corrected the Post Change for lead frame lead-lock from Yes to No. Updated the notification subject, description of change and affected CPN list to include LAN9210 and LAN9211 device families. Provided estimated first ship date to be on October 31, 2021.

November 15, 2021: Re-issued final notification. Attached the qualification report.

The change described in this PCN does not alter Microchip's current regulatory compliance regarding the material content of the applicable products.

Attachments:

[PCN_ASER-06ZMCM207_Qual_Report.pdf](#)

[PCN_ASER-06ZMCM207_Pre and Post Change Summary.pdf](#)

Please contact your local [Microchip sales office](#) with questions or concerns regarding this notification.

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If you wish to [change your PCN profile, including opt out](#), please go to the [PCN home page](#) select login and sign into your myMicrochip account. Select a profile option from the left navigation bar and make the applicable selections.

Affected Catalog Part Numbers (CPN)

LAN9303-ABZJ

LAN9303I-ABZJ

LAN9303I-ABZJ-TR

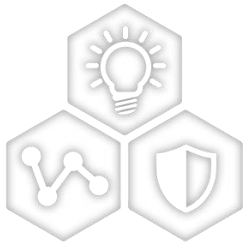
LAN9211-ABZJ

LAN9210-ABZJ

CCB 4630
Pre and Post Change Summary
PCN #: ASER-06ZMCM207



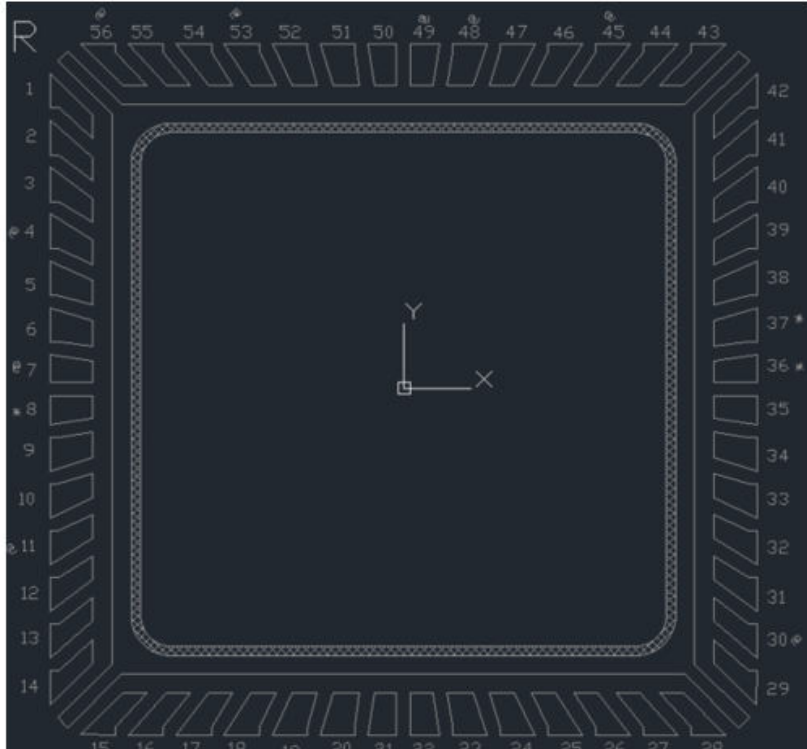
A Leading Provider of Smart, Connected and Secure Embedded Control Solutions



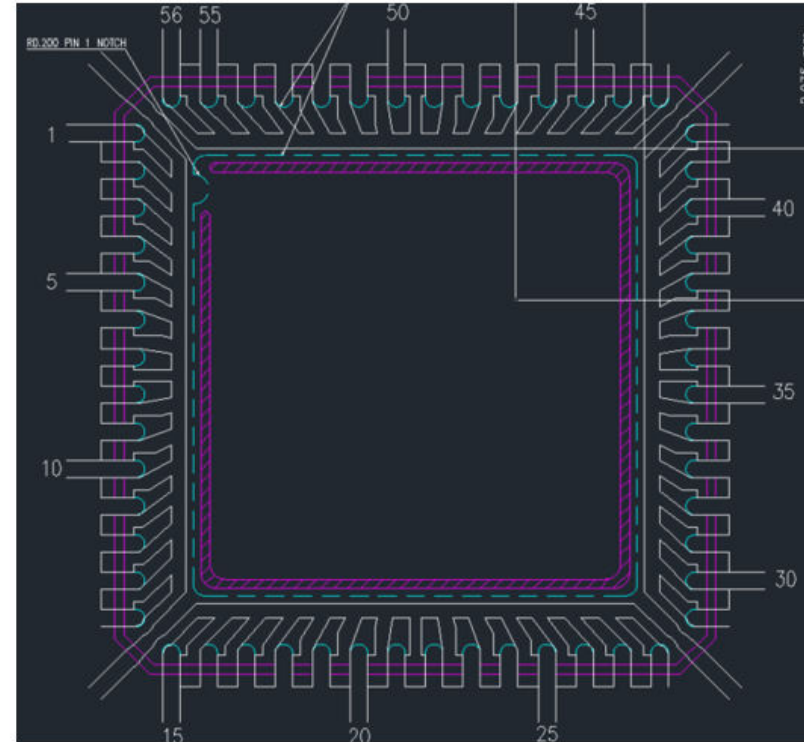
SMART | CONNECTED | SECURE

Lead frame Comparison

ASE



STA





QUALIFICATION REPORT SUMMARY
RELIABILITY LABORATORY

PCN#: ASER-06ZMCM207

Date
November 2, 2021

**Qualification of STA as an additional assembly site for
selected LAN9303, LAN9210 and LAN9211 device families
available in 56L VQFN (8x8x0.9mm) package.**



MICROCHIP PACKAGE QUALIFICATION REPORT

Purpose	Qualification of STA as an additional assembly site for selected LAN9303, LAN9210 and LAN9211 device families available in 56L VQFN (8x8x0.9mm) package.
CN	ES361355
QUAL ID	R2100817
MP CODE	TA3017RTXB0C
Part No.	LAN9303I-ABZJ
Bonding No.	BDM-002969 Rev. A
<u>Package</u>	
Type	56L VQFN
Package size	8 x 8 x 0.9 mm
<u>Lead Frame</u>	
Paddle size	236 x 236 mils
Material	C194
Surface	Double Ring
Process	Etched
Lead Lock	No
Part Number	R002-3646X
<u>Material</u>	
Epoxy	8290
Wire	CuPdAu wire
Mold Compound	G700E
Plating Composition	Matte Sn



MICROCHIP PACKAGE QUALIFICATION REPORT

Manufacturing Information

Assembly Lot No.	Wafer Lot No.	Date Code
STA-221300006.000	TC11922050505.100	2125YMV
STA-221300008.000	TC11922050505.100	2125YPR
STA-221300007.000	TC11922050505.100	2125YPH

Result

Pass Fail _____

56L VQFP (8x8x0.9 mm) assembled by STA pass reliability test per QCI-39000.
This package was qualified the Moisture/Reflow Sensitivity Classification Level 3 at 260°C
reflow temperature per IPC/JEDEC J-STD-020E standard.

PACKAGE QUALIFICATION REPORT

Test Number (Reference)	Test Condition	Standard/ Method	Qty. (Acc.)	Def/SS	Result	Remarks
<u>Precondition</u> <u>Prior Perform</u> <u>Reliability Tests</u> (At MSL Level 3)	<p>Electrical Test: +25°C and 100°C System: EX_ANALOG</p> <p>Bake 150°C, 24 hrs System: CHINEE</p> <p>30°C/60%RH Moisture Soak 192 hrs. System: TABAI ESPEC Model PR-3SPH</p> <p>3x Convection-Reflow 265°C max System: Vitronics Soltec MR1243</p> <p>Electrical Test: +25°C and 100°C System: EX_ANALOG</p>	<p>JESD22- A113</p> <p>JIP/ IPC/JEDEC J-STD-020E</p>	<p>693(0)</p>	<p>693</p> <p>693</p> <p>693</p> <p>693</p> <p>0/693</p>	<p>Pass</p>	<p>Good Devices</p>

PACKAGE QUALIFICATION REPORT

Test Number (Reference)	Test Condition	Standard/ Method	Qty. (Acc.)	Def/SS.	Result	Remarks
Temp Cycle	Stress Condition: -65°C to +150°C, 500 Cycles System: TABAI ESPEC TSA-70H	JESD22-A104		231		Parts had been pre-conditioned at 260°C 77 units / lot
	Electrical Test: +100°C System: EX_ANALOG		231(0)	0/231	Pass	
	Stress Condition: -65°C to +150°C, 1000 Cycles System: TABAI ESPEC TSA-70H			231		
	Electrical Test: +100°C System: EX_ANALOG		231(0)	0/231	Pass	
UNBIASED-HAST	Bond Strength: Wire Pull (> 2.50 grams) Bond Shear (>12.60 grams)		15 (0)	0/15	Pass	
			15 (0)	0/15	Pass	
	Stress Condition: +130°C/85%RH, 96 hrs. System: HAST 6000X	JESD22-A118		231		Parts had been pre-conditioned at 260°C 77 units / lot
	Electrical Test: +25°C System: EX_ANALOG		231(0)	0/231	Pass	
Stress Condition: +130°C/85%RH, 192 hrs. System: HAST 6000X			231			
Electrical Test: +25°C System: EX_ANALOG	231(0)		0/231	Pass		

PACKAGE QUALIFICATION REPORT

Test Number (Reference)	Test Condition	Standard/ Method	Qty. (Acc.)	Def/SS.	Result	Remarks
High Temperature Storage Life	Stress Condition: Bake 175°C, 504 hrs System: SHEL LAB	JESD22-A103		45		45 units
	Electrical Test: +25°C and 100°C System: EX_ANALOG		45(0)	0/45	Pass	
Solderability Temp 245°C	Steam Aging: Temp 93°C,8Hrs System: SAS-3000 Solder Dipping: Solder Temp.245°C Solder material:Pb Free Sn 95.5Ag3.9 Cu0.6 System: ERSA RA 2200D Visual Inspection: External Visual Inspection	J-STD-002	22 (0)	22 22 0/22	Pass	
Physical Dimensions	Physical Dimension, 10 units from 1 lot	JESD22-B100/B108	30(0) Units	0/30	Pass	
Bond Strength Data Assembly	Wire Pull (> 3.00 grams)	Mil. Std. 883-2011	30 (0) Wires	0/30	Pass	
	Bond Shear (> 8.00 grams)	CDF-AEC-Q100-001	30 (0) bonds	0/30	Pass	